## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | KIM ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0149733	10-2002	Lyu et al.	349/155
	В	US-2003/0156235	08-2003	Kuzuhara et al.	349/96
	С	US-2004/0001175	01-2004	Ito, Yoji	349/117
	D	US-2004/0180149	09-2004	Shibue et al.	428/001.1
	E	US-2002/0140882	10-2002	Kitagawa et al.	349/96
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	κ	US-		·	
	L	US-		·	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø	_				
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

	TOTAL ATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	V						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.